

IEC SYSTEM FOR CONFORMITY TESTING AND
CERTIFICATION OF ELECTRICAL EQUIPMENT (IECEE)
CB SCHEME

SYSTEME GEI D'ESSAIS DE CONFORMITE ET DE CERTIFICATION
DES EQUIPEMENTS ELECTRIQUES (IECEE)
METHODE OC

CB TEST CERTIFICATE CERTIFICAT D'ESSAI OC

Product
Produit

Embedded Compact CCD Reader

Name and address of the applicant
Nom et adresse du demandeur

Microscan Systems Inc
1201 SW 7th St
Renton, WA 98057, USA

Name and address of the manufacturer
Nom et adresse du fabricant

Microscan Systems Inc
1201 SW 7th St
Renton, WA 98057, USA

Name and address of the factory
Nom et adresse de l'usine

Microscan Systems Inc
1201 SW 7th St
Renton, WA 98057, USA

Rating and principal characteristics
Valeurs nominales et caractéristiques principales

5 Vdc, 1 Watt max. (for reference only)

Trademark (if any)
Marque de fabrique (si elle existe)

MICROSCAN

Model / Type Ref.
Ref. de type

MS-2

Additional information (if necessary)
Information complémentaire (si nécessaire)

This CB Test Report comprises 5 enclosures.

A sample of the product was tested and found
to be in conformity with
Un échantillon de ce produit a été essayé et a été
considéré conforme à la

PUBLICATION

EDITION

IEC 60950-1 (2001) First Edition,
Additional evaluation to CENELEC Common Modifications also included.
See Test Report for National Differences.

as shown in the Test Report Ref. No.
which forms part of this Certificate
comme indiqué dans le Rapport d'essais numéro
de référence qui constitue partie de ce Certificat

E137142-A13-CB-1

This CB Test Certificate is issued by the National Certification Body
Ce Certificat d'essai OC est établi par l'Organisme National de Certification



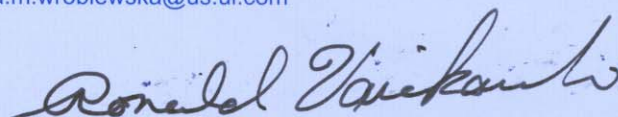
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Date:

Issued: 2009 January 8

Signature:



Ronald Vaickauski